

Notice of References Cited	Application/Control No. 10/594,015		Applicant(s)/Patent Under Reexamination GARCIA ET AL.	
	Examiner Victor Kostak		Art Unit 2422	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0044532 A1	03-2004	Karstens, Christopher K.	704/271
*	B	US-6,781,635 B1	08-2004	Takeda, Genyo	348/552
*	C	US-6,741,293 B1	05-2004	Obuchi, Masashi	348/554
*	D	US-6,650,376 B1	11-2003	Obitsu, Toshiro	348/730
*	E	US-7,106,382 B2	09-2006	Shiotsu, Shinichi	348/555
*	F	US-5,900,913 A	05-1999	Tults, Juri	348/468
*	G	US-5,758,599	06-1998	Glanville, Jerold N.	119/77
*	H	US-5,701,599	12-1997	Aihara, Fumikazu	455/186.1
*	I	US-5,900,908 A	05-1999	Kirkland, C. Eric	348/62
*	J	US-2002/0000984	01-2002	Asai et al.	345/211
*	K	US-2002/0021760	02-2002	Harris et al.	375/240.26
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.